

Search Notes**Application/Control No.**

10/541,015

Examiner

SANG KIM

Applicant(s)/Patent under Reexamination

SCHLEUCHER, HEIKO

Art Unit

3654

SEARCHED

Class	Subclass	Date	Examiner
242	580 579 402 172	8/21/2007	SK
24	600.9	8/21/2007	SK
24	601.2-4	8/21/2007	SK
24	601.7-9	8/21/2007	SK
24	698.1-3	8/21/2007	SK

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
John Nguyen: 242/402, 172 Dean Kramer: 294/No search	8/14/2007	SK
James Brittain: 24/600.9, 601.2-4, 601.7-9, 698.1-3	8/21/2007	SK